

# FDS6162N7

## 20V N-Channel PowerTrench® MOSFET

### General Description

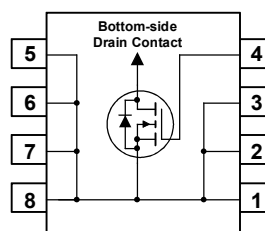
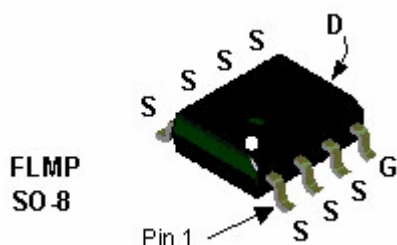
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low  $R_{DS(ON)}$  in a small package.

### Applications

- Synchronous rectifier
- DC/DC converter

### Features

- 23 A, 20 V  $R_{DS(ON)} = 3.5\text{ m}\Omega @ V_{GS} = 4.5\text{ V}$   
 $R_{DS(ON)} = 5.0\text{ m}\Omega @ V_{GS} = 2.5\text{ V}$
- High performance trench technology for extremely low  $R_{DS(ON)}$
- High power and current handling capability
- Fast switching
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size



### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

| Symbol         | Parameter  | Rated       | Units |
|----------------|--|-------------|-------|
| $V_{DSS}$      | Drain-Source Voltage                             | 20          | V     |
| $V_{GSS}$      | Gate-Source Voltage                              | $\pm 12$    | V     |
| $I_D$          | Drain Current – Continuous (Note 1a)             | 23          | A     |
|                | – Pulsed   | 60          |       |
| $P_D$          | Power Dissipation (Note 1a)                      | 3.0         | W     |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range | -55 to +150 | °C    |

### Thermal Characteristics

|                 |   |     |      |
|-----------------|---|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient (Note 1a) | 40  | °C/W |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case              | 0.5 |      |

### Package Marking and Ordering Information

| Device Marking | Device    | Reel Size | Tape width | Quantity   |
|----------------|-----------|-----------|------------|------------|
| FDS6162N7      | FDS6162N7 | 13"       | 12mm       | 2500 units |

## Electrical Characteristics

$T_A = 25^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

### Off Characteristics

|                                      |   |   |    |    |      |                      |
|--------------------------------------|---|---|----|----|------|----------------------|
| $BV_{DSS}$                           | Drain-Source Breakdown Voltage            | $V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$               | 20 |    |      | V                    |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$ |    | 13 |      | mV/ $^\circ\text{C}$ |
| $I_{DSS}$                            | Zero Gate Voltage Drain Current           | $V_{DS} = 16\text{ V}, V_{GS} = 0\text{ V}$                 |    |    | 1    | $\mu\text{A}$        |
| $I_{GSSF}$                           | Gate-Body Leakage, Forward                | $V_{GS} = 12\text{ V}, V_{DS} = 0\text{ V}$                 |    |    | 100  | nA                   |
| $I_{GSSR}$                           | Gate-Body Leakage, Reverse                | $V_{GS} = -12\text{ V}, V_{DS} = 0\text{ V}$                |    |    | -100 | nA                   |

### On Characteristics (Note 2)

|  |  |   |     |                   |                   |                      |
|--|--|---|-----|-------------------|-------------------|----------------------|
| $V_{GS(th)}$                           | Gate Threshold Voltage                         | $V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$   | 0.6 | 0.9               | 1.5               | V                    |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$   |     | -4                |                   | mV/ $^\circ\text{C}$ |
| $R_{DS(on)}$                           | Static Drain-Source On-Resistance              | $V_{GS} = 4.5\text{ V}, I_D = 23\text{ A}$<br>$V_{GS} = 2.5\text{ V}, I_D = 19\text{ A}$<br>$V_{GS} = 4.5\text{ V}, I_D = 23\text{ A}, T_J = 125^\circ\text{C}$ |     | 2.9<br>3.6<br>4.1 | 3.5<br>5.0<br>6.2 | m $\Omega$           |
| $g_{FS}$                               | Forward Transconductance                       | $V_{DS} = 5\text{ V}, I_D = 23\text{ A}$  |     | 119               |                   | S                    |

### Dynamic Characteristics

|            |                              |  |  |      |  |          |
|------------|------------------------------|--|--|------|--|----------|
| $C_{iss}$  | Input Capacitance            | $V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1.0\text{ MHz}$ |  | 5521 |  | pF       |
| $C_{oss}$  | Output Capacitance           |  |  | 1473 |  | pF       |
| $C_{riss}$ | Reverse Transfer Capacitance |  |  | 706  |  | pF       |
| $R_G$      | Gate Resistance              | $V_{GS} = 15\text{ mV}, f = 1.0\text{ MHz}$                          |  | 1.3  |  | $\Omega$ |

### Switching Characteristics (Note 2)

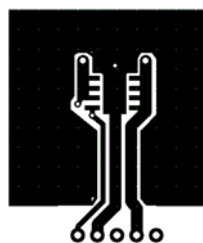
|              |                     |   |  |      |     |    |
|--------------|---------------------|---|--|------|-----|----|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD} = 10\text{ V}, I_D = 1\text{ A},$<br>$V_{GS} = 4.5\text{ V}, R_{GEN} = 6\ \Omega$ |  | 20   | 32  | ns |
| $t_r$        | Turn-On Rise Time   |   |  | 25   | 40  | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |   |  | 85   | 136 | ns |
| $t_f$        | Turn-Off Fall Time  |   |  | 55   | 88  | ns |
| $Q_g$        | Total Gate Charge   | $V_{DS} = 10\text{ V}, I_D = 23\text{ A},$<br>$V_{GS} = 4.5\text{ V}$                     |  | 52   | 73  | nC |
| $Q_{gs}$     | Gate-Source Charge  |   |  | 9    |     | nC |
| $Q_{gd}$     | Gate-Drain Charge   |   |  | 14.5 |     | nC |

### Drain-Source Diode Characteristics and Maximum Ratings

|          |   |  |  |     |     |    |
|----------|---|--|--|-----|-----|----|
| $I_S$    | Maximum Continuous Drain-Source Diode Forward Current |  |  | 2.5 | A   |    |
| $V_{SD}$ | Drain-Source Diode Forward Voltage                    | $V_{GS} = 0\text{ V}, I_S = 2.5\text{ A}$ (Note 2)           |  | 0.6 | 1.2 | V  |
| $t_{rr}$ | Diode Reverse Recovery Time                           | $I_F = 23\text{ A},$<br>$dI_F/dt = 100\text{ A}/\mu\text{s}$ |  | 42  |     | nS |
| $Q_{rr}$ | Diode Reverse Recovery Charge                         |  |  | 52  |     | nC |

#### Notes:

- $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a)  $40^\circ\text{C}/\text{W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper



b)  $85^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size paper

- Pulse Test: Pulse Width <  $300\ \mu\text{s}$ , Duty Cycle <  $2.0\%$

## Typical Characteristics

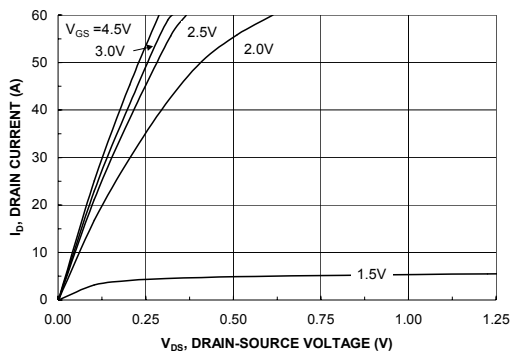


Figure 1. On-Region Characteristics.

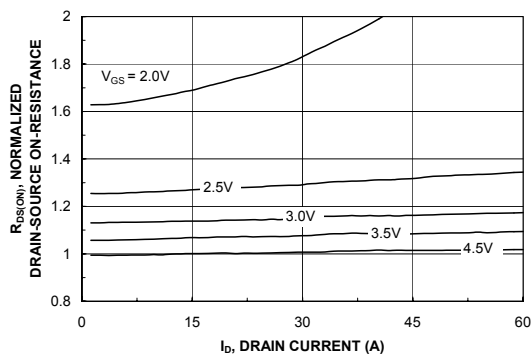


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

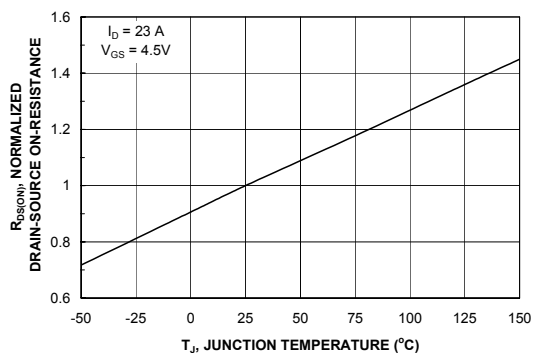


Figure 3. On-Resistance Variation with Temperature.

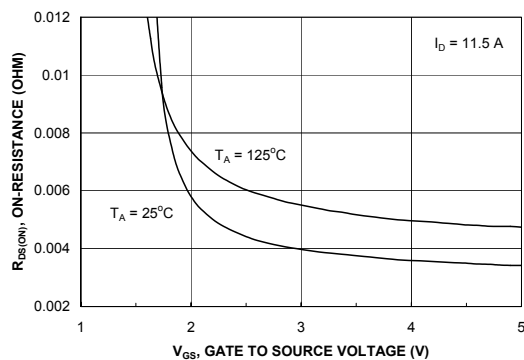


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

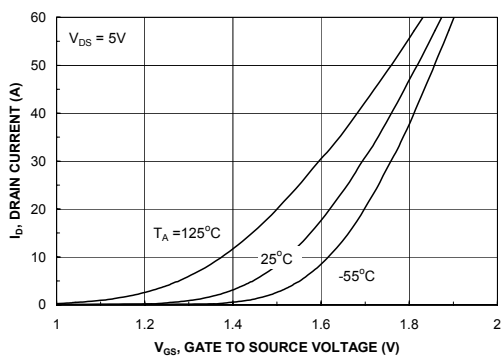


Figure 5. Transfer Characteristics.

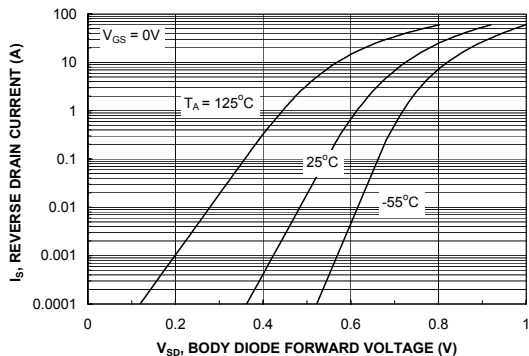
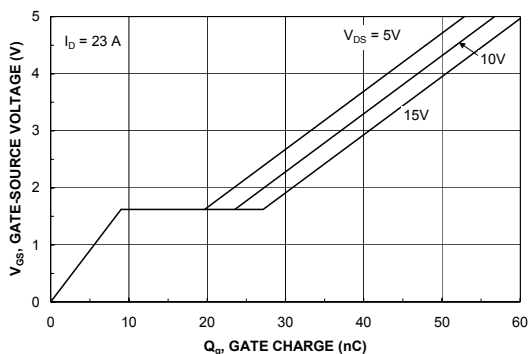
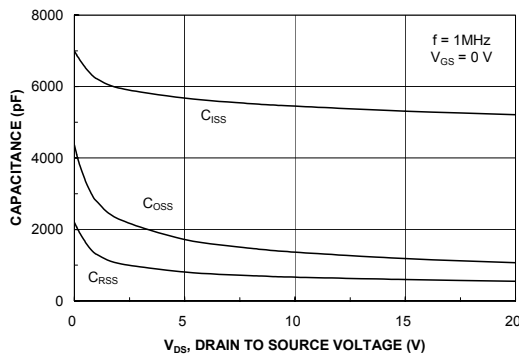


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

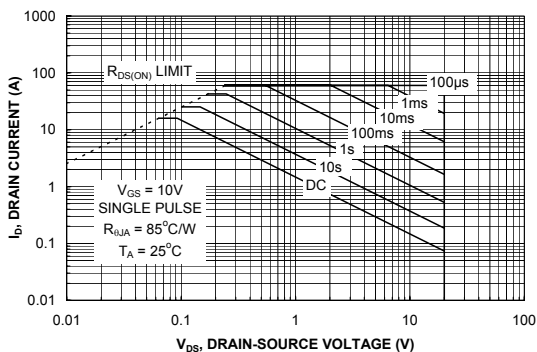
## Typical Characteristics



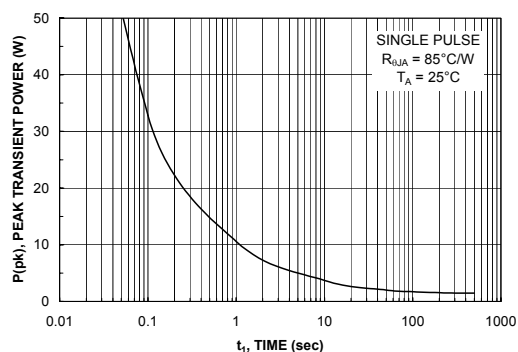
**Figure 7. Gate Charge Characteristics.**



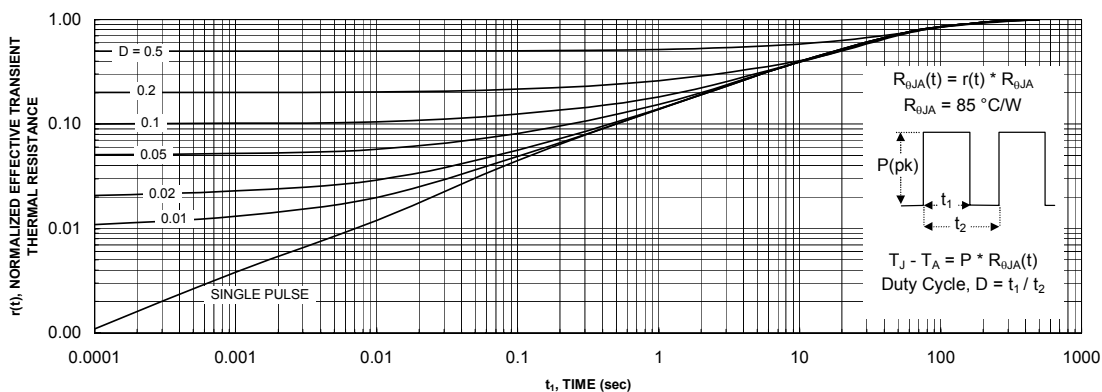
**Figure 8. Capacitance Characteristics.**



**Figure 9. Maximum Safe Operating Area.**



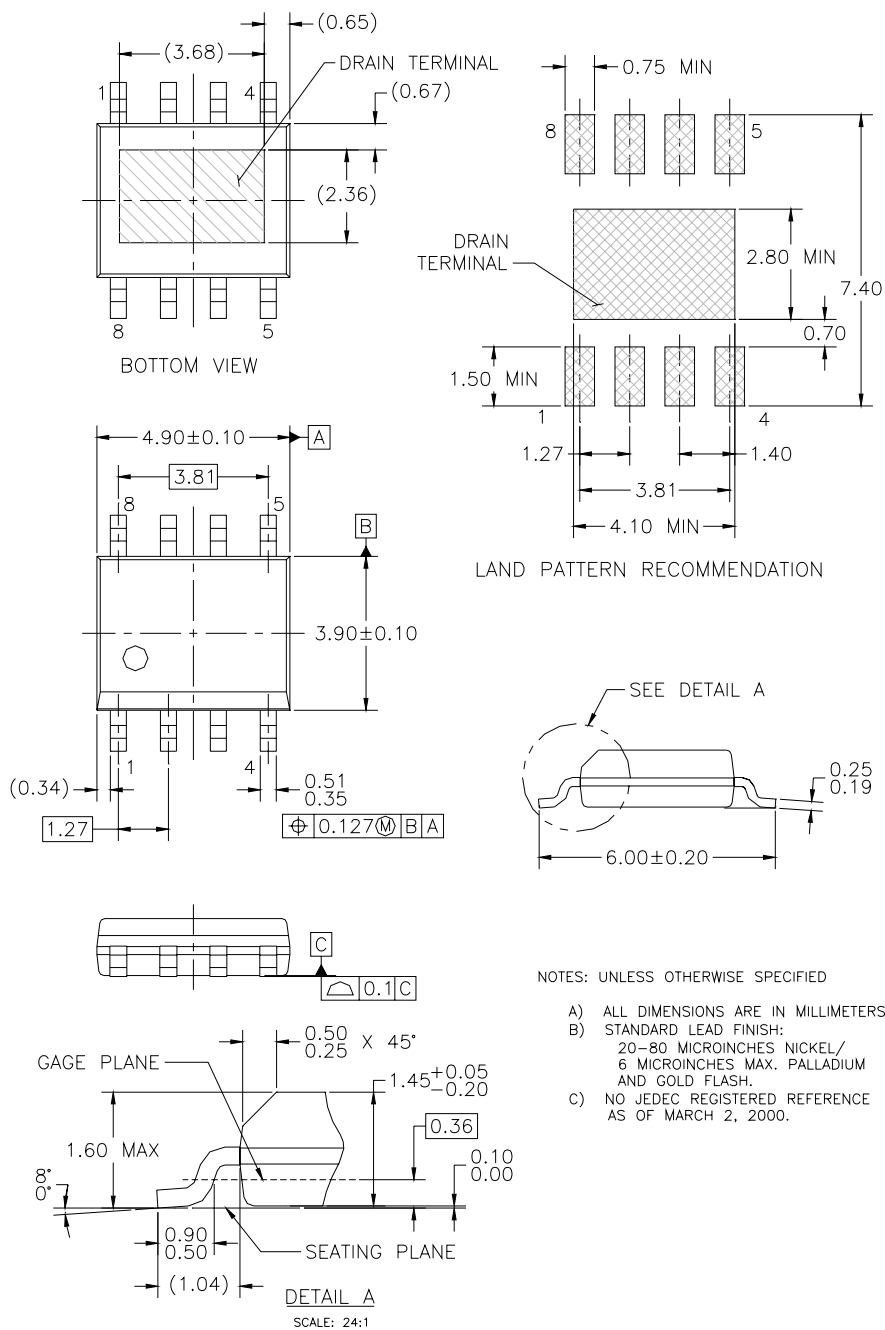
**Figure 10. Single Pulse Maximum Power Dissipation.**



**Figure 11. Transient Thermal Response Curve.**

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

## Dimensional Outline and Pad Layout



NOTES: UNLESS OTHERWISE SPECIFIED

- A) ALL DIMENSIONS ARE IN MILLIMETERS.
- B) STANDARD LEAD FINISH:  
20-80 MICROINCHES NICKEL/  
6 MICROINCHES MAX. PALLADIUM  
AND GOLD FLASH.
- C) NO JEDEC REGISTERED REFERENCE  
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| CoolFET™                             | FASTr™              | MicroFET™          | PowerTrench®        | SuperSOT™-6     |
| CROSSVOLT™                           | FRFET™              | MicroPak™          | QFET™               | SuperSOT™-8     |
| DOME™                                | GlobalOptoisolator™ | MICROWIRE™         | QS™                 | SyncFET™        |
| EcoSPARK™                            | GTO™                | MSX™               | QT Optoelectronics™ | TinyLogic®      |
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| EnSigna™                             | µC™                 | OCX™               | RapidConfigure™     | UHC™            |
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